

Device Modeling Report

COMPONENTS: THYRISTOR
PART NUMBER: MCR265-8
MANUFACTURER: MOTOROLA SEMICONDUCTOR



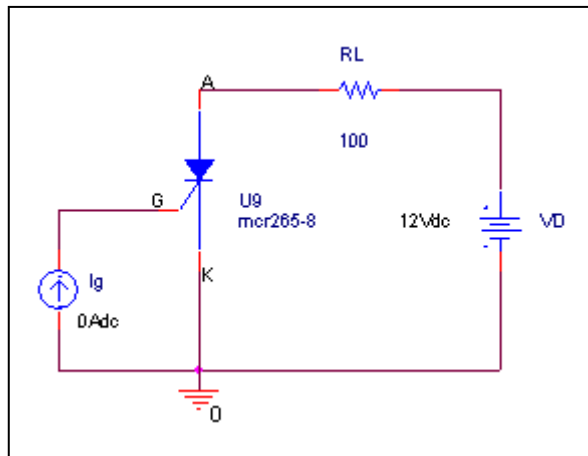
Bee Technologies Inc.

DIODE MODEL

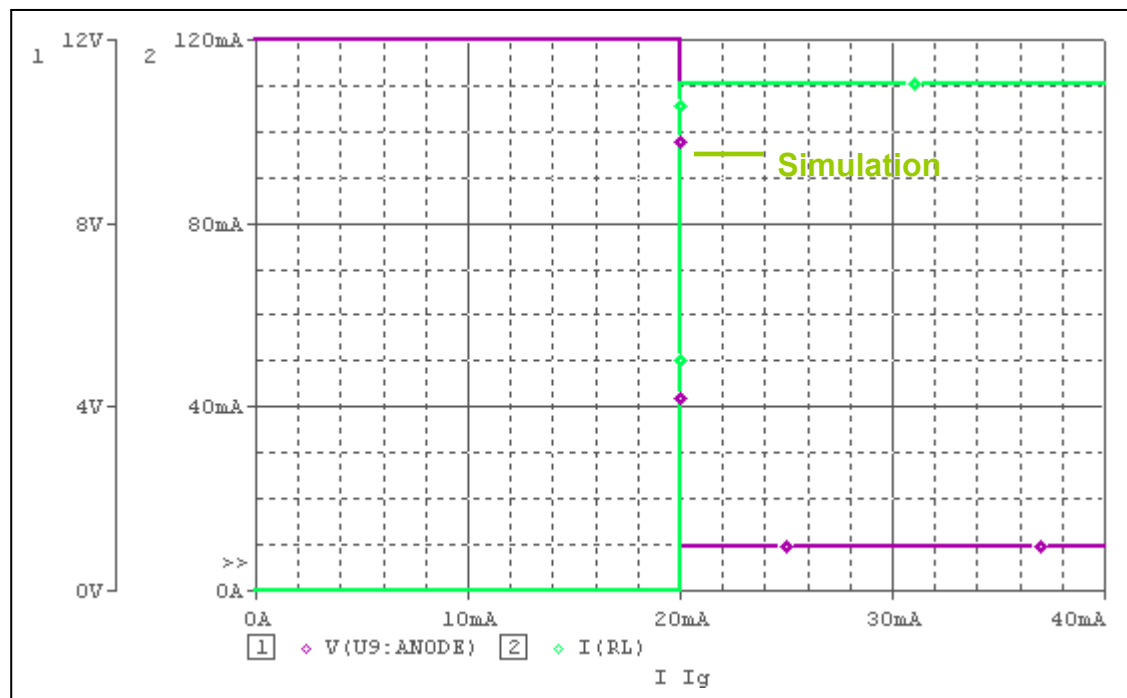
Pspice model Parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time

IG-VT Characteristic

Evaluation Circuit



Simulation result

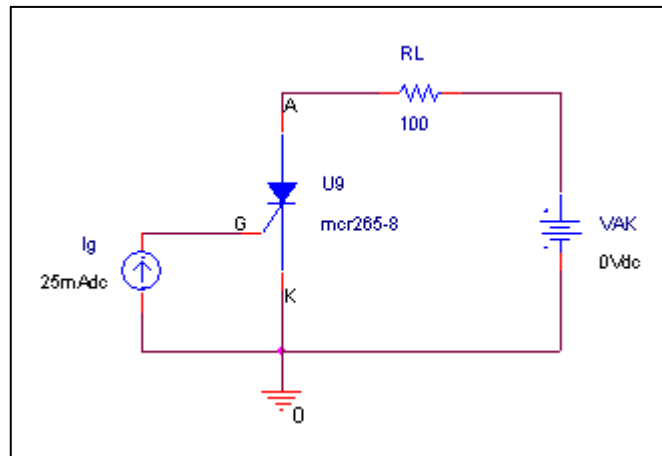


Comparison Table

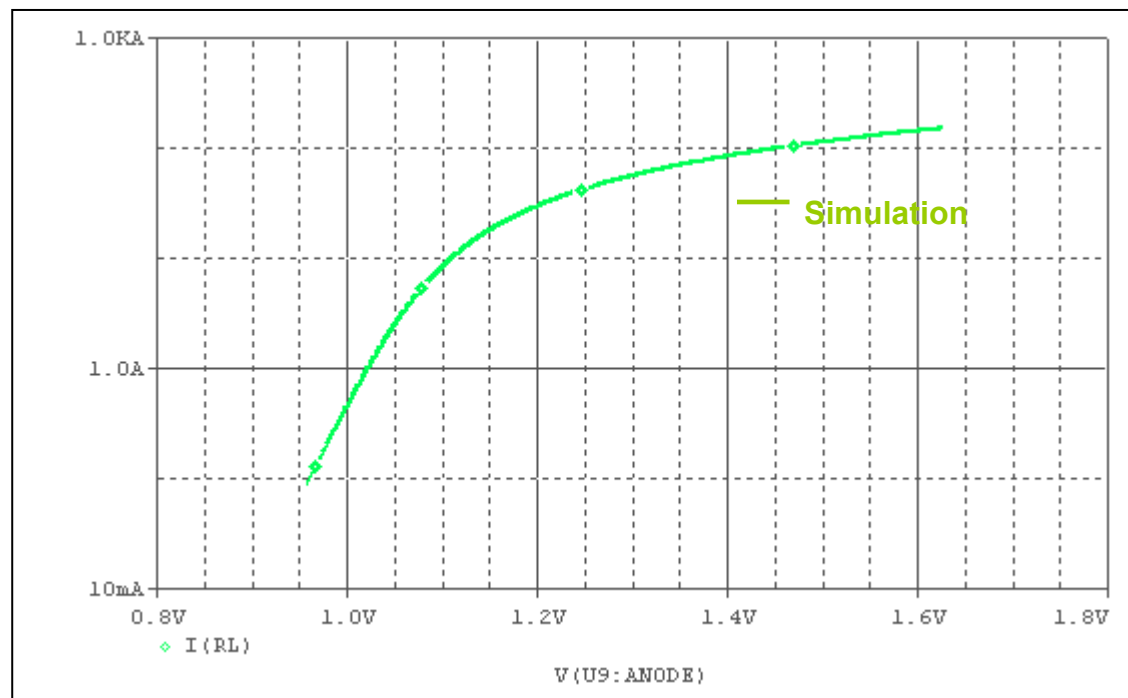
	Measurement	Simulation	% Error
I_{GT} (mA)	20	20	0
V_{GT} (V)	1	0.962594	-3.74060

ITM-VTM Characteristic

Evaluation Circuit



Simulation result

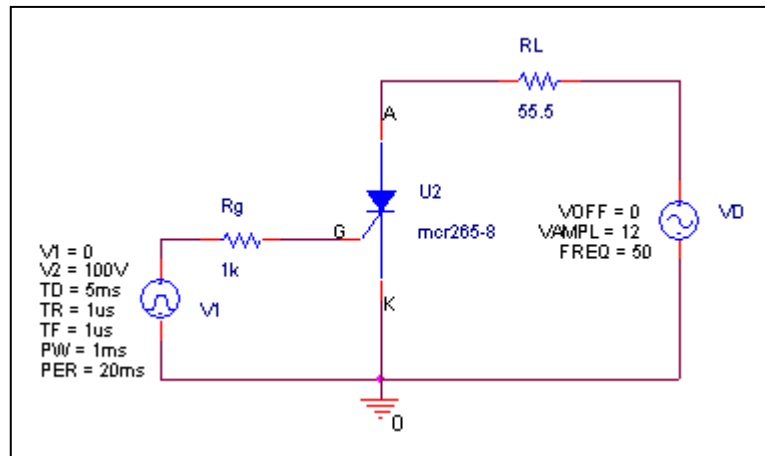


Comparison Table

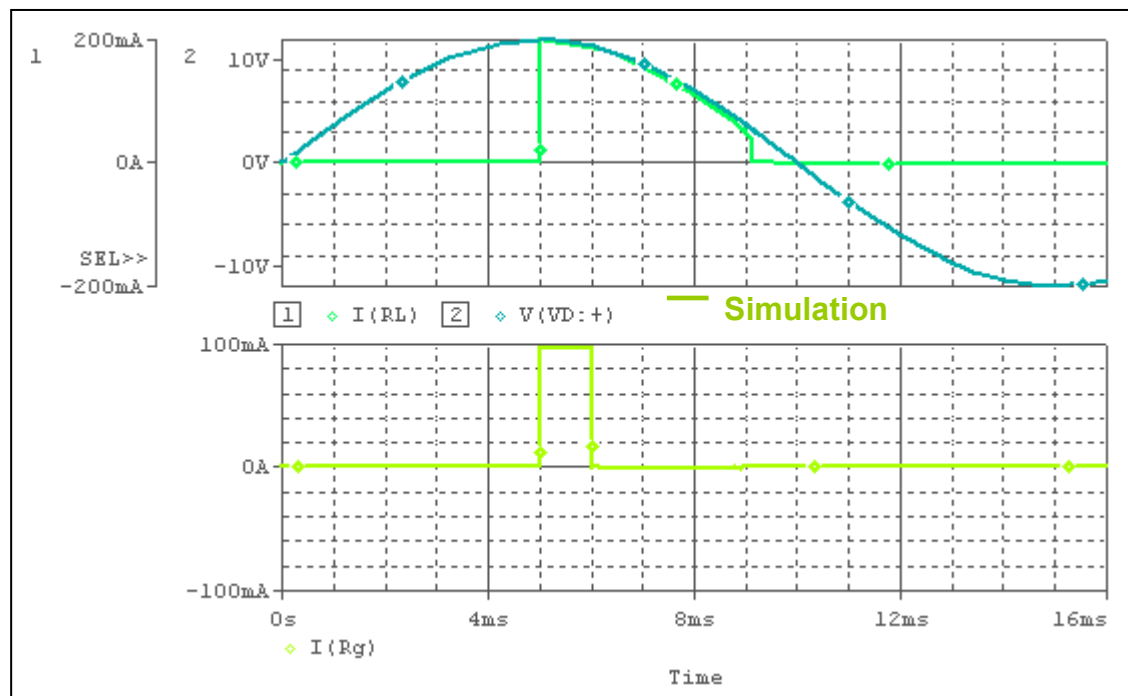
At ITM=110A	Measurement	Simulation	% Error
VTM(V)	1.5	1.4911	-0.59333

Holding Characteristic (IH)

Evaluation Circuit



Simulation result

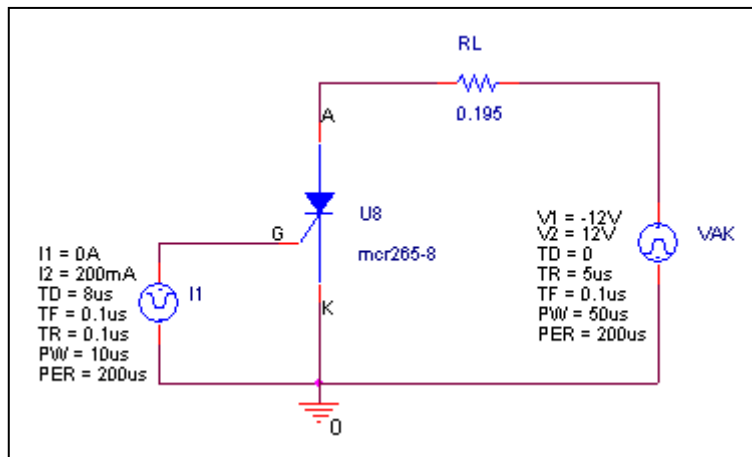


Comparison Table

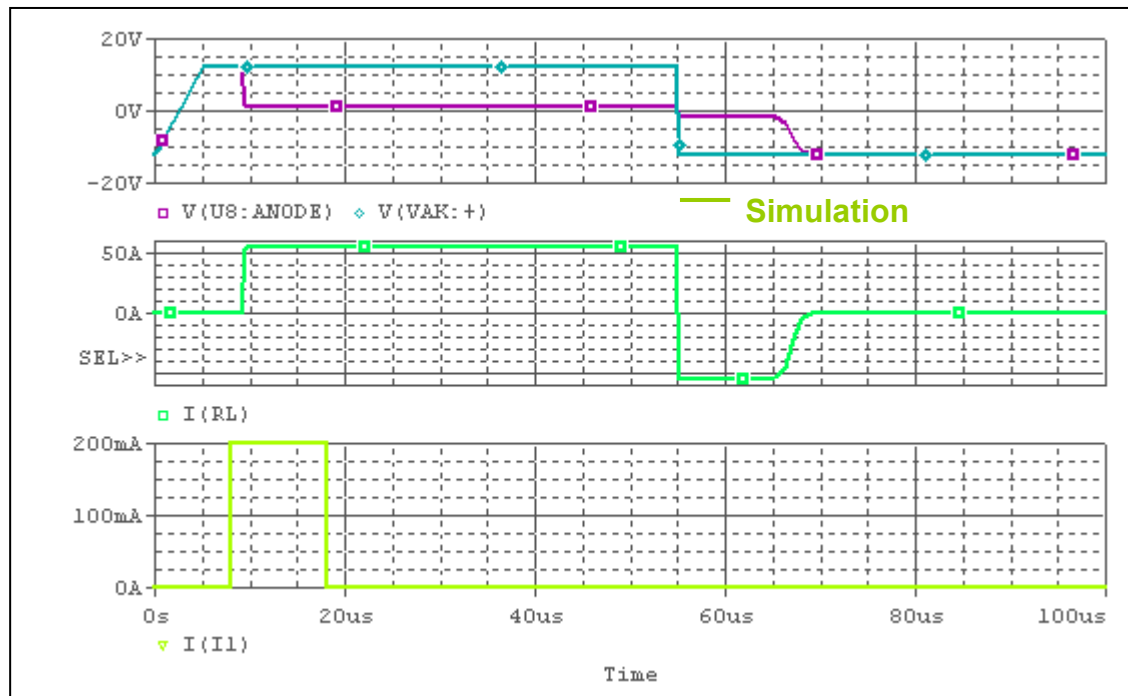
VAK=12V	Measurement	Simulation	% Error
IH(mA)	30	29.913	-0.29000

Switching Time Characteristic

Evaluation Circuit



Simulation result



Comparison Table

	Measurement	Simulation	%Error
Ton(us)	1.5	1.4998	-0.01333